

# Mapping surface plasmons in thin film solar cells using energy-filtered transmission electron microscopy

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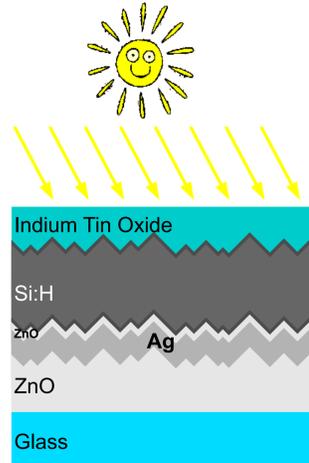
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## Surface plasmons on Ag thin films

The light trapped by thin film Si solar cells is improved when they are grown on rough substrates. The use of a rough Ag reflector layer results in additional optical absorption, partly through the creation of surface plasmon polaritons [1].

In thin film solar cells, Ag surface plasmons are suspected to absorb part of the visible light in the 1-3.5eV range.

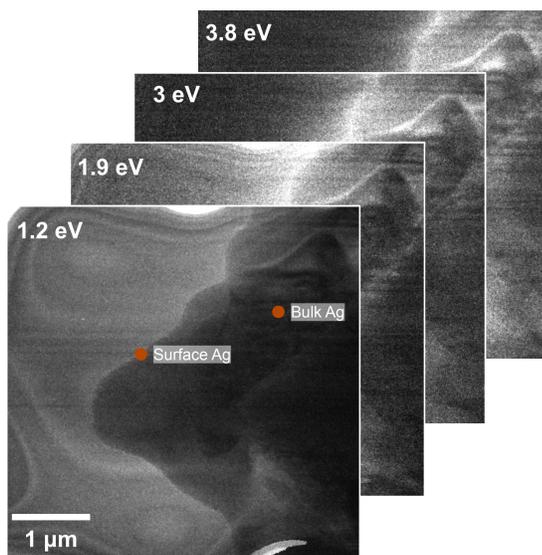


## Method

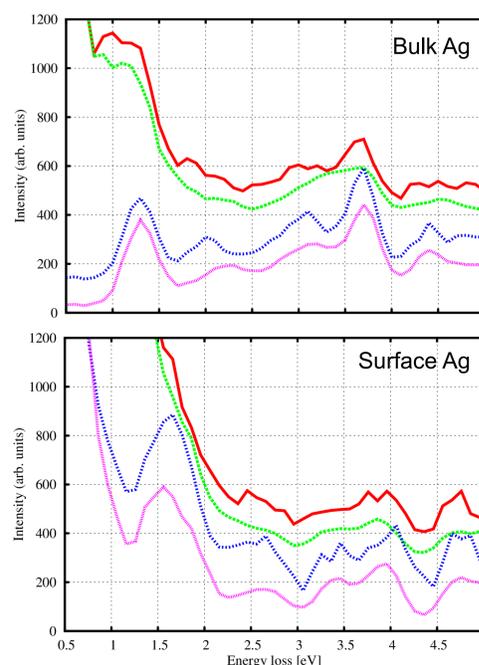
In this work, we map plasmonic absorption in Ag layers in real solar cells using energy-filtered (EF)TEM, followed by post-process noise filtering and deconvolution (using a Richardson–Lucy algorithm).

We use EFTEM images collected in a chromatic aberration corrected microscope, which results in better spatial resolution than using STEM-EELS [2].

## Improvement of signal/noise ratio using principal component analysis and Richardson-Lucy deconvolution



EFTEM series recorded with a monochromated beam, a 0.2 eV energy-selecting slit width and a 0.1 eV energy step.



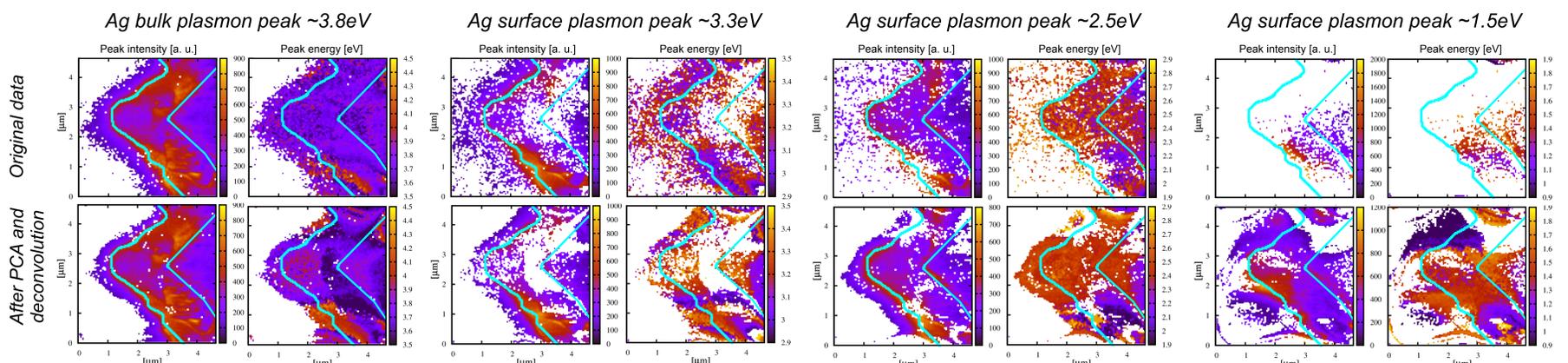
→ Principal component analysis allows noise reduction before applying the Richardson-Lucy algorithm.

→ 10 iterations of the Richardson-Lucy algorithm does not introduce artifact peaks.

→ Finding peak positions and energy shifts using an automatic procedure becomes possible after the use of principal component analysis and the Richardson-Lucy algorithm.

— Original spectra  
 - - - Spectra filtered using the 30 1<sup>st</sup> principal components  
 ····· Spectra deconvoluted with 10 iterations of the RL algorithm  
 ····· Spectra filtered using 30 1<sup>st</sup> principal components followed by 10 iterations of the RL algorithm

## Intensity and energy loss maps for the different Ag plasmon peaks



- Numerical processing is beneficial for energies below 3eV
- Plasmon peak energy across the sample can be determined with high spatial resolution
- The three surface plasmon resonances can be resolved using a combination of EFTEM and numerical processing
- The energy resolution is still limited by the energy steps used during acquisition and will be improved in future experiments

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[1] F.-J. Haug et al. *Journal of Applied Physics* 104 (2008) 064509  
 [2] J. Nelayah et al. *Nature Physics* 3 (2007) 348